## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination	
10645097	LEE, CHIOU-HAUN	
Examiner	Art Unit	
Patel, Kanji	2624	

SEARCHED						
Class	Subclass	Date	Examiner			
382	254, 312	1/28/07	KBP			
385	120 .	2/2/07	KBP			
358	1.9, 3.03, 3.05	2/2/07	KBP			
430	394	2/2/-7	KBP			

SEARCH NOTES					
Search Notes	Date	Examiner			
INVENTOR SEARCH IN PALM	1/26/07	KBP			
EAST (US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM TDB)	1/26/07	KBP			
EAST (US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM TDB)	1/29/07	1BP			
NPL-IEEE XPLORE SEARCH	1/29/07	KBP			
INTEREFERENCE SEARCH HISTORY PRINTOUT	. 2/2/07	KBP			
EAST (USPAT)	2/2/07	KBP			

INTERFERENCE SEARCH							
Class		Subclass	Date	Examiner			
358	1.9		4/11/07	KBP			